


<b>Search Notes</b>  	<b>Application/Control No.</b>  10583602	<b>Applicant(s)/Patent Under Reexamination</b>  CHOI ET AL.
	<b>Examiner</b>  Filip Zec	<b>Art Unit</b>  3744

SEARCHED			
Class	Subclass	Date	Examiner
62	404, 408, 419	1/14/2010	FZ
454	(limited text search only - see search history printout)	1/14/2010	FZ

SEARCH NOTES		
Search Notes	Date	Examiner
Discussed class 62 with B. Doerrler and 454 with H. Kosanovic	1/14/2010	FZ
See EAST search history notes	1/14/2010	FZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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